## P－Channel Enhancement Mode Power MOSFET

## Description

The HM2309APR uses advanced trench technology and design to provide excellent $\mathrm{R}_{\mathrm{DS}(\mathrm{ON})}$ with low gate charge ．This device is well suited for use as a load switch or in PWM applications．

## General Features

－$V_{D S}=-60 \mathrm{~V}, I_{D}=-5 \mathrm{~A}$
$R_{D S(O N)}<120 \mathrm{~m} \Omega @ V_{G S}=-10 \mathrm{~V}$
$\mathrm{R}_{\mathrm{DS}(\mathrm{ON})}<170 \mathrm{~m} \Omega$＠ $\mathrm{V}_{\mathrm{GS}}=-4.5 \mathrm{~V}$
－High density cell design for ultra low Rdson
－Fully characterized avalanche voltage and current
－Excellent package for good heat dissipation

## Application

－Load switch
－PWM application


Schematic diagram


SOT－89－3L top view

## Package Marking and Ordering Information

| Device Marking | Device | Device Package | Reel Size | Tape width | Quantity |
| :---: | :---: | :---: | :---: | :---: | :---: |
| HM2309APR | HM2309APR | SOT－89－3L | $\varnothing 180 \mathrm{~mm}$ | 8 mm | 3000 units |

## Absolute Maximum Ratings（ $\mathbf{T}_{\mathrm{C}}=\mathbf{2 5}{ }^{\circ} \mathrm{Cunless}$ otherwise noted）

| Parameter | Symbol | Limit | Unit |
| :--- | :---: | :---: | :---: |
| Drain－Source Voltage | $\mathrm{V}_{\mathrm{DS}}$ | -60 | V |
| Gate－Source Voltage | $\mathrm{V}_{\mathrm{GS}}$ | $\pm 20$ | V |
| Drain Current－Continuous | $\mathrm{I}_{\mathrm{D}}$ | -5 | A |
| Pulsed Drain Current | $\mathrm{I}_{\mathrm{DM}}$ | -15 | A |
| Maximum Power Dissipation | $\mathrm{P}_{\mathrm{D}}$ | 1.5 | W |
| Operating Junction and Storage Temperature Range | $\mathrm{T}_{\mathrm{J}}, \mathrm{T}_{\text {STG }}$ | -55 To 150 | ${ }^{\circ} \mathrm{C}$ |

## Thermal Characteristic

| Thermal Resistance，Junction－to－Ambient ${ }^{(\text {Note 2）}}$ | R $_{\text {өJA }}$ | 83.3 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| :--- | :---: | :---: | :---: |

Electrical Characteristics（ $\mathrm{T}_{\mathrm{C}}=\mathbf{2 5}{ }^{\circ} \mathrm{C}$ unless otherwise noted）

| Parameter | Symbol | Condition | Min | Typ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Off Characteristics |  |  |  |  |  |  |
| Drain－Source Breakdown Voltage | BV ${ }_{\text {DSs }}$ | $\mathrm{V}_{\mathrm{GS}}=0 \mathrm{~V} \mathrm{I}_{\mathrm{D}}=-250 \mu \mathrm{~A}$ | －60 | － | － | V |
| Zero Gate Voltage Drain Current | IDSs | $V_{D S}=-60 \mathrm{~V}, \mathrm{~V}_{G S}=0 \mathrm{~V}$ | － | － | －1 | $\mu \mathrm{A}$ |
| Gate－Body Leakage Current | $\mathrm{I}_{\text {gss }}$ | $\mathrm{V}_{\mathrm{GS}}= \pm 20 \mathrm{~V}, \mathrm{~V}_{\mathrm{DS}}=0 \mathrm{~V}$ | － | － | $\pm 100$ | nA |
| $\text { On Characteristics }{ }^{\text {(Note 3) }}$ |  |  |  |  |  |  |
| Gate Threshold Voltage | $\mathrm{V}_{\text {GS（th）}}$ | $V_{D S}=V_{G S}, I_{D}=-250 \mu \mathrm{~A}$ | －1．5 | －2．2 | －3．0 | V |
| Drain－Source On－State Resistance | $\mathrm{R}_{\mathrm{DS} \text {（ON）}}$ | $V_{G S}=-10 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=-5 \mathrm{~A}$ | － | 106 | 120 | $\mathrm{m} \Omega$ |
|  |  | $\mathrm{V}_{G S}=-4.5 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=-3 \mathrm{~A}$ | － | 135 | 170 | $\mathrm{m} \Omega$ |
| Forward Transconductance | g Fs | $\mathrm{V}_{\mathrm{DS}}=-5 \mathrm{~V}, \mathrm{l}_{\mathrm{D}}=-5 \mathrm{~A}$ | － | 10 | － | S |
| Dynamic Characteristics ${ }^{\text {（Note4）}}$ |  |  |  |  |  |  |
| Input Capacitance | $\mathrm{C}_{\text {lss }}$ | $\begin{gathered} \mathrm{V}_{\mathrm{DS}}=-30 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}, \\ \mathrm{~F}=1.0 \mathrm{MHz} \end{gathered}$ | － | 930 | － | PF |
| Output Capacitance | $\mathrm{C}_{\text {oss }}$ |  | － | 85 | － | PF |
| Reverse Transfer Capacitance | $\mathrm{C}_{\text {rss }}$ |  | － | 35 | － | PF |
| Switching Characteristics ${ }^{\text {（Note 4）}}$ |  |  |  |  |  |  |
| Turn－on Delay Time | $\mathrm{t}_{\mathrm{d}(\mathrm{on})}$ | $\begin{gathered} V_{D D}=-30 V, R_{L}=7.5 \Omega, \\ V_{G S}=-10 V, R_{G}=3 \Omega \end{gathered}$ | － | 8 | － | nS |
| Turn－on Rise Time | $\mathrm{t}_{\mathrm{r}}$ |  | － | 4 | － | nS |
| Turn－Off Delay Time | $\mathrm{t}_{\mathrm{d} \text {（off）}}$ |  | － | 32 | － | nS |
| Turn－Off Fall Time | $\mathrm{t}_{\mathrm{f}}$ |  | － | 7 | － | nS |
| Total Gate Charge | $\mathrm{Q}_{\mathrm{g}}$ | $\begin{gathered} V_{D S}=-30, I_{D}=-5 A, \\ V_{G S}=-10 \mathrm{~V} \end{gathered}$ | － | 25 | － | nC |
| Gate－Source Charge | $\mathrm{Q}_{\mathrm{gs}}$ |  | － | 3 | － | nC |
| Gate－Drain Charge | $\mathrm{Q}_{\mathrm{gd}}$ |  | － | 7 | － | nC |
| Drain－Source Diode Characteristics |  |  |  |  |  |  |
| Diode Forward Voltage ${ }^{\text {（Note 3）}}$ | $V_{\text {SD }}$ | $\mathrm{V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{IS}_{\mathrm{S}}=-5 \mathrm{~A}$ | － |  | －1．2 | V |
| Diode Forward Current ${ }^{\text {（Note 2）}}$ | Is |  | － | － | －5 | A |
| Reverse Recovery Time | $\mathrm{trr}_{\text {r }}$ | $\begin{gathered} \mathrm{T}_{J}=25^{\circ} \mathrm{C}, \mathrm{I}_{\mathrm{F}}=-5 \mathrm{~A} \\ \mathrm{di} / \mathrm{dt}=-100 \mathrm{~A} / \mu \mathrm{s}^{\text {(Note3 })} \end{gathered}$ | － | 25 |  | nS |
| Reverse Recovery Charge | Qrr |  | － | 31 |  | nC |

## Notes：

1．Repetitive Rating：Pulse width limited by maximum junction temperature．
2．Surface Mounted on FR4 Board， $\mathrm{t} \leq 10 \mathrm{sec}$ ．
3．Pulse Test：Pulse Width $\leq 300 \mu s$ ，Duty Cycle $\leq 2 \%$ ．
4．Guaranteed by design，not subject to production

## Test Circuit

1）$E_{A S}$ test Circuit


2）Gate charge test Circuit


3）Switch Time Test Circuit


## HM2309APR

## Typical Electrical and Thermal Characteristics（Curves）



Figure 1 Output Characteristics


Figure 2 Transfer Characteristics


Figure 3 Rdson－Drain Current
 $\mathrm{T}_{\mathrm{J}}$－Junction Temperature（ ${ }^{\circ} \mathrm{C}$ ）
Figure 4 Rdson－Junction Temperature


Figure 5 Gate Charge


Figure 6 Source－Drain Diode Forward

## HM2309APR


-Vds Drain-Source Voltage (V)
Figure 7 Capacitance vs Vds


Figure 8 Safe Operation Area


Figure 9 BV $_{\text {Dss }}$ vs Junction Temperature


Figure 10 ID Current De-rating


Figure 11 Normalized Maximum Transient Thermal Impedance

SOT－89－3L Package Information


| Symbol | Dimensions In Millimeters |  | Dimensions In Inches |  |
| :---: | :---: | :---: | :---: | :---: |
|  | Min | Max | Min | Max |
| A | 1.400 | 1.600 | 0.055 | 0.063 |
| b | 0.320 | 0.520 | 0.013 | 0.020 |
| b1 | 0.400 | 0.580 | 0.016 | 0.023 |
| c | 0.350 | 0.440 | 0.014 | 0.017 |
| D | 4.400 | 4.600 | 0.173 |  |
| D1 | 1.550 REF． |  | 0.181 |  |
| E | 2.300 | 2.600 | 0.091 | 0.102 |
| E1 | 3.940 | 4.250 | 0.155 |  |
| R | 1.500 TYP． |  | 0.060 TYP． |  |
| e1 | $3.000 ~ T Y P . ~$ |  | 0.118 TYP． |  |
| L | 0.900 | 1.200 | 0.035 | 0.047 |

## Notes

1．All dimensions are in millimeters．
2．Tolerance $\pm 0.10 \mathrm{~mm}$（ 4 mil ）unless otherwise specified
3．Package body sizes exclude mold flash and gate burrs．Mold flash at the non－lead sides should be less than 5 mils．
4．Dimension $L$ is measured in gauge plane．
5．Controlling dimension is millimeter，converted inch dimensions are not necessarily exact．

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